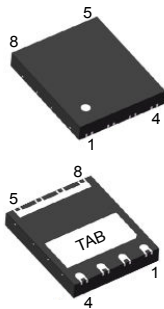
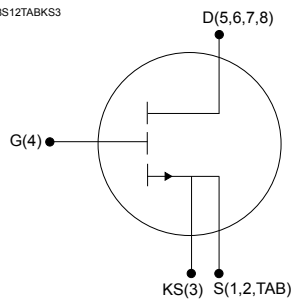


700 V, 74 mΩ typ., 21 A, e-mode PowerGaN transistor



**PowerFLAT 5x6 HV
for PowerGaN**

G4D5678S12TABKS3



Features

Order code	V_{DS}	$R_{DS(on)}$ max.	I_D	Series
SGT100R70FDC	700 V	100 mΩ	21 A	G-HEMT

- Enhancement mode normally off transistor
- Very high switching speed
- High power management capability
- Extremely low capacitances
- Zero reverse recovery charge
- ESD safeguard

Applications

- AC-DC converters
- DC-DC converters
- USB type-C PD adapters and quick chargers
- Wireless charging

Description

The **SGT100R70FDC** is a 700 V, 21 A e-mode PowerGaN transistor. The resulting device provides extremely low conduction losses, high current capability and ultra-fast switching operation to enable high power density and unbeatable efficiency performances.

Product status link

[SGT100R70FDC](#)

Product summary

Order code	SGT100R70FDC
Marking	100R70F
Package	PowerFLAT 5x6 HV for PowerGaN
Packing	Tape and reel

1 Electrical ratings

$T_C = 25\text{ °C}$ unless otherwise specified.

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	700 ⁽¹⁾	V
	Drain-source voltage (transient, $t_p < 200\text{ }\mu\text{s}$)	800	
V_{GS}	Gate-source voltage	-6 to 7	V
I_D	Drain current (continuous)	21	A
I_{DM}	Pulse drain current ($t_p = 10\text{ }\mu\text{s}$)	41	A
P_{TOT}	Total power dissipation at $T_C = 25\text{ °C}$	107	W
T_{stg}	Storage temperature range	-55 to 150	°C
T_J	Operating junction temperature range		°C

1. Recommended continuous maximum bus voltage during switching operations should not exceed 450 V.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance, junction-to-case	1.16	°C/W
R_{thJA} ⁽¹⁾	Thermal resistance, junction-to-ambient	69.94	°C/W

1. When mounted on a standard 1 inch² area of FR-4 PCB with 2-oz copper.

2 Electrical characteristics

$T_C = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Table 3. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{DSS}	Drain-source leakage current	$V_{GS} = 0\text{ V}, V_{DS} = 700\text{ V}$		0.8		μA
		$V_{GS} = 0\text{ V}, V_{DS} = 700\text{ V}, T_J = 125\text{ }^{\circ}\text{C}$		9		
I_{GSS}	Gate-source leakage current	$V_{DS} = 0\text{ V}, V_{GS} = 6\text{ V}$		90		μA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 18.3\text{ mA}$	1.2	1.7	2.5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 6\text{ V}, I_D = 0.5\text{ A}$		74	100	$\text{m}\Omega$
		$V_{GS} = 6\text{ V}, I_D = 6\text{ A}, T_J = 125\text{ }^{\circ}\text{C}$		148		

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input capacitance	$V_{GS} = 0\text{ V}, V_{DS} = 400\text{ V}, f = 100\text{ kHz}$	-	130	-	pF
C_{oss}	Output capacitance		-	47	-	pF
C_{rss}	Reverse transfer capacitance		-	0.5	-	pF
$C_{o(er)}^{(1)}$	Equivalent output capacitance energy related	$V_{GS} = 0\text{ V}, V_{DS} = 0\text{ to }400\text{ V}$	-	62.9	-	pF
$C_{o(tr)}^{(2)}$	Equivalent output capacitance time related		-	83.4	-	pF
R_g	Intrinsic gate resistance	$f = 5\text{ MHz}, I_D = 0\text{ A}$	-	7	-	Ω
V_{plat}	Gate plateau voltage	$V_{DS} = 400\text{ V}, I_D = 6\text{ A}$	-	2.1	-	V
Q_g	Total gate charge	$V_{GS} = 0\text{ to }6\text{ V}, V_{DS} = 400\text{ V}, I_D = 6\text{ A}$	-	3.4	-	nC
Q_{gs}	Gate-source charge		-	0.3	-	nC
Q_{gd}	Gate-drain charge		-	1.3	-	nC
Q_{rr}	Reverse recovery charge	$V_{GS} = 0\text{ V}, V_{DS} = 400\text{ V}$	-	0	-	nC
Q_{oss}	Output charge		-	32.7	-	nC

- $C_{o(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to the stated value.
- $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to the stated value.

Table 5. Reverse conduction

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{SD}	Source-drain reverse voltage	$V_{GS} = 0\text{ V}, I_{SD} = 6\text{ A}$	-	2.4	-	V

Revision history

Table 6. Document revision history

Date	Revision	Changes
08-Oct-2025	1	First release.

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